

L Number	Hits	Search Text	DB	Time stamp
8	2	6,098,030.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 19:29
15	2	5,873,053.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 19:30
22	2	5,838,578.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 19:30
29	2	6,363,490.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 19:30
36	2	5,291,607.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 19:31
-	1724	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3) with temperature with ((integrated adj circuit) or computer or microprocessor or VLSI)) and (sensor\$1 with (thermal or temperature))) and ((controller or processor or comparator or microprocessor) with (interpret\$5 or analy\$4 or compar\$5) with (temperature or thermal)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 19:28
-	540	(((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3) with temperature with ((integrated adj circuit) or computer or microprocessor or VLSI)) and (sensor\$1 with (thermal or temperature))) and ((controller or processor or comparator or microprocessor) with (interpret\$5 or analy\$4 or compar\$5) with (temperature or thermal))) and (memory same ((sensor\$1 or response or control) with (temperature or thermal)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 12:18
-	57	(((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3) with temperature with ((integrated adj circuit) or computer or microprocessor or VLSI)) and (sensor\$1 with (thermal or temperature))) and ((controller or processor or comparator or microprocessor) with (interpret\$5 or analy\$4 or compar\$5) with (temperature or thermal))) and (memory same ((sensor\$1 or response or control) with (temperature or thermal))) and (temperature with (integrated adj circuit)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 19:33
-	28873	(monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 20:39

-	12666	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (sensor\$1 with (thermal or temperature))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 20:44
-	6702	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (sensor\$1 with (thermal or temperature))) and ((controller or processor or comparator or microprocessor or management) with (interpret\$5 or analy\$4 or compar\$5 or control\$4) with (temperature or thermal))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 20:43
-	9	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and ((active or passive) adj (thermal or temperature) adj sensor\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 20:57
-	0	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (active with calibration with ((thermal or temperature) adj sensor\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:11
-	2	(active with calibration with ((thermal or temperature) adj sensor\$1))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:03
-	1	((calibration adj sensor) with ((thermal or temperature) adj sensor\$1)) and (integrated adj circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:04
-	22	(calibration adj sensor) with ((thermal or temperature) adj sensor\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:06
-	7	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (calibration with sensor\$1 with substrate)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:47
-	0	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (measurement adj buffer\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:48
-	9774	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (controller)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 22:02

237	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (controller with (temperature or thermal) with (integrated adj circuit))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:53
89	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (controller with (temperature or thermal) with (integrated adj circuit)) and (memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:53
9	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (controller with (temperature or thermal) with (integrated adj circuit)) and (memory with (threshold or limit))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 21:53
12	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and ((temperature or thermal) adj profile) with (integrated adj circuit))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 22:09
70	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and (window adj size)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 22:10
0	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and ((window adj size) same (temperature or thermal) same count\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 22:11
8	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and ((window adj size) same (temperature or thermal))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 22:19
84	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and ((temperature or thermal) with (threshold or limit) with count\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 22:20
24	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3 or manag\$5) with (temperature or thermal) with ((integrated adj circuit) or IC or computer or microprocessor or VLSI)) and ((temperature or thermal) with (threshold or limit) with count\$3 with (exceed\$3 or above or over))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/20 22:31
109	702/132.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/21 09:54

	1733	((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3) with temperature with ((integrated adj circuit) or computer or microprocessor or VLSI)) and (sensor\$1 with (thermal or temperature))) and ((controller or processor or comparator or microprocessor) with (interpret\$5 or analy\$4 or compar\$5) with (temperature or thermal))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 13:04
	25535	((buffer or register or memory or cache) with wire\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 13:05
	36	((((monitor\$3 or control\$4 or determin\$3 or measur\$3 or obtain\$3 or assess\$3 or detect\$3) with temperature with ((integrated adj circuit) or computer or microprocessor or VLSI)) and (sensor\$1 with (thermal or temperature))) and ((controller or processor or comparator or microprocessor) with (interpret\$5 or analy\$4 or compar\$5) with (temperature or thermal))) and (((buffer or register or memory or cache) with wire\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/28 13:05